Search Notes

Δ.	Application/Control No.	Applicant(s)/Patent under Reexamination
1	0/749,208	BAEK, JI-HOON
E	xaminer	Art Unit
la	aura tso	2875

SEARCHED					
Class	Subclass	Date	Examiner		
362	549				
	507				
	546				
	382				
	368				
	418				
	420				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
362	549				
	368				
	382				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		-		
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